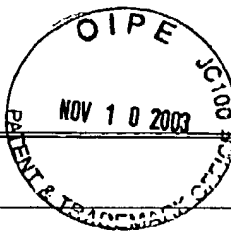


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 218797US0		SERIAL NO. 10/060,200	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Masato OSHIKA, et al.			
				FILING DATE February 1, 2002		GROUP 1751	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	Hei 11-349453	12/21/99	JAPAN	XXX	1	
	AP	Sho 51-151-341	12/25/76	JAPAN	XXX	1	
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>Euse Gudo</i>					Date Considered <i>3/9/04</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
218797US0SERIAL NO.
10/060,200

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Masato OSHIKA, et al.FILING DATE
February 1, 2002GROUP
1751

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
OK	AO	5-238923	09/17/1993	JAPAN (with English Abstract)	—	X
OK	AP	5-78228	03/30/1993	JAPAN (with English Abstract and corr. GB 2259717)	—	X
OK	AQ	2259717	03/24/1993	GREAT BRITAIN	—	
OK	AR	10-245327	09/14/1998	JAPAN (with English Abstract)	—	X
OK	AS	11-349453	12/21/1999	JAPAN (with English Abstract)	—	X
	AT				—	
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	
		<input type="checkbox"/> Additional References sheet(s) attached

Examiner

2152 2/10/02

Date Considered

3/9/04

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Masato OSHIKA, et al.			
				FILING DATE February 1, 2002		GROUP 1751	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
CE	AA	6,204,229	03/20/2001	Y. HASEGAWA, et al.	510	101	
CE	AB	5,500,154	03/19/1996	D. R. BACON, et al.	252	551	
	AC						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
CE	AO	10-259121	09/29/1998	JAPAN (with English Abstract and corr. US 6,204,229)	—		X
CE	AP	10-259122	09/29/1998	JAPAN (with English Abstract)	—		X
CE	AQ	10-259123	09/29/1998	JAPAN (with English Abstract)	—		X
CE	AR	10-507789	07/28/1998	JAPAN (with English Abstract and corr. US 5,500,154)	—		X
CE	AS	5-310543	11/22/1993	JAPAN (with English Abstract)	—		X
CE	AT	2000-16929	01/18/2000	JAPAN (with English Abstract)	—		X
CE	AU	2000-290680	10/17/2000	JAPAN (with English Abstract)	—		X
CE	AV	7-103964	04/21/1995	JAPAN (with English Abstract)	—		X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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